

Integrated Device Technology, Inc.

OCTAL BUS SWITCH

IDT74FST3244
IDT74FST32244

FEATURES:

- Bus switches provide zero delay paths
- Extended commercial range of -40°C to $+85^{\circ}\text{C}$
- Low switch on-resistance
- TTL-compatible input and output levels
- ESD > 2000V per MIL-STD-883, Method 3015;
> 200V using machine model (C = 200pF, R = 0)
- Available in QSOP, TSSOP, SOIC, SSOP, and PDIP
- Hot insertion capability
- Very low power dissipation

DESCRIPTION:

The FST3244/32244 belong to IDT's family of Bus switches. Bus switch devices perform the function of connecting or isolating two ports without providing any inherent current sink or source capability. Thus they generate little or no noise of their own while providing a low resistance path for an external driver.

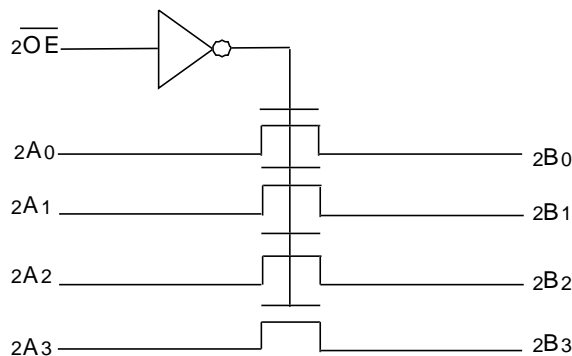
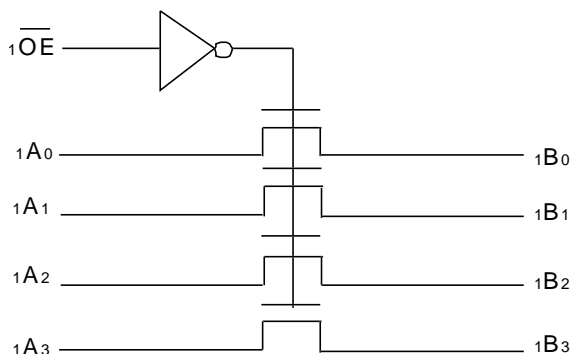
These devices connect input and output ports through an n-channel FET. When the gate-to-source junction of this FET is adequately forward-biased, the device conducts and the resistance between input and output ports is small. Without adequate bias on the gate-to-source junction of the FET, the FET is turned off, therefore with no VCC applied, the device has not insertion capability.

The low on-resistance and simplicity of the connection between input and output ports reduces the delay in this path to close to zero.

The FST32244 integrates terminating resistors in the device, thus eliminating the need for external 25Ω series resistors.

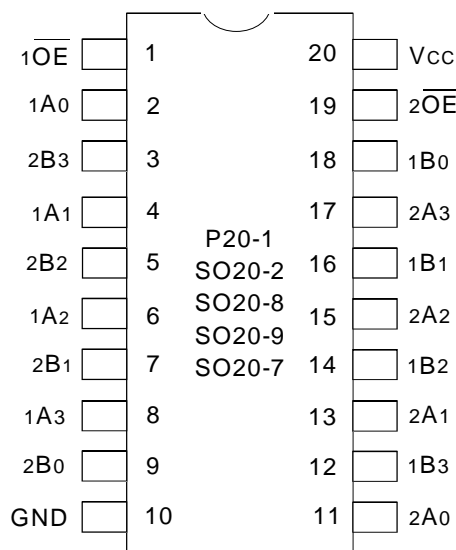
The FST3244 and FST32244 are octal TTL-compatible bus switches. The $\overline{\text{OE}}$ pins provide output enable control for all 8 bits. These devices are pin-compatible with and functionally similar to the FCT244T.

FUNCTIONAL BLOCK DIAGRAM



3255 drw 01

PIN CONFIGURATION



DIP/SOIC/SSOP
QSOP/TSSOP
TOP VIEW

3255 drw 02

PIN DESCRIPTION

Pin Names	Description
xOE	Output Enable Inputs (Active LOW)
xAx	A Port Bits
xBx	B Port Bits

3255 tbl 01

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INDUSTRIAL TEMPERATURE RANGE

JANUARY 1999

FUNCTION TABLE⁽¹⁾

1OE	2OE	Description
H	H	DISCONNECT
L	H	CONNECT 1A to 1B
H	L	CONNECT 2A to 2B
L	L	CONNECT 1A to 1B and 2A to 2B

3255 tbl 02

NOTE:

1. H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care

CAPACITANCE⁽¹⁾

Symbol	Parameter	Conditions ⁽²⁾	Typ.	Unit
C _{IN}	Control Input Capacitance		8	pF
C _{I/O}	Switch Input/Output Capacitance	Switch Off	13	pF

3255 lnk 03

NOTES:

1. Capacitance is characterized but not tested.
2. T_A = 25°C, f = 1MHz, V_{IN} = 0V, V_{OUT} = 0V

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Description	Max.	Unit
V _{TERM} ⁽²⁾	Terminal Voltage with Respect to GND	−0.5 to +7.0	V
T _{STG}	Storage Temperature	−65 to +150	°C
I _{OUT}	Maximum Continuous Channel Current	128	mA

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NOTES:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. V_{CC}, Control and Switch terminals.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Condition Apply Unless Otherwise Specified:

Operating Conditions: T_A = −40°C to +85°C, V_{CC} = 5.0V ±5%

Symbol	Parameter	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Unit
V _{IH}	Control Input HIGH Voltage	Guaranteed Logic HIGH Level	2.0	—	—	V
V _{IL}	Control Input LOW Voltage	Guaranteed Logic LOW Level	—	—	0.8	V
I _{IH}	Control Input HIGH Current	V _{CC} = Max. V _I = V _{CC} V _I = GND	—	—	±1	μA
I _{IL}	Control Input LOW Current		—	—	±1	μA
I _{OZH}	Current During	V _{CC} = Max., V _O = 0 to 5V	—	—	±1	μA
I _{OZL}	Bus Switch DISCONNECT		—	—	±1	μA
V _{IK}	Clamp Diode Voltage	V _{CC} = Min., I _{IN} = −18mA	—	−0.7	−1.2	V
I _{OFF}	Switch Power Off Leakage	V _{CC} = 0V, V _{IN} or V _O ≤ 5.5V	—	—	±1	μA
I _{CC}	Quiescent Power Supply Current	V _{CC} = Max., V _{IN} = GND or V _{CC}	—	0.1	3	μA

3255 lnk 05

BUS SWITCH IMPEDANCE OVER OPERATING RANGE

Following Condition Apply Unless Otherwise Specified:

Operating Conditions: T_A = −40°C to +85°C, V_{CC} = 5.0V ±5%

Symbol	Parameter	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Unit
R _{ON}	Switch CONNECT Resistance A to B ⁽²⁾	V _{CC} = Min., V _{IN} = 0.0V	3xxx	5	7	Ω
		I _{ON} = 30mA	32xxx	17	28	
		V _{CC} = Min., V _{IN} = 2.4V	3xxx	10	15	
		I _{ON} = 15mA	32xxx	20	35	
I _{OS}	Short Circuit Current, A to B ⁽³⁾	A(B) = 0V, B(A) = V _{CC}	100	—	—	mA

3255 tbl 06

NOTES:

1. Typical values are at V_{CC} = 5.0V, +25°C ambient.
2. The voltage drop between the indicated ports divided by the current through the switch.
3. Not more than one output should be shorted at one time. Duration of the test should not exceed one second.

POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾		Min.	Typ. ⁽²⁾	Max.	Unit
ΔI_{CC}	Quiescent Power Supply Current TTL Inputs HIGH	$V_{CC} = \text{Max.}$ $V_{IN} = 3.4V^{(3)}$		—	0.5	1.5	mA
I_{CCD}	Dynamic Power Supply Current ^(4,5)	$V_{CC} = \text{Max.}$ Outputs Open 1 Enable Pin Toggling 50% Duty Cycle	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	120	160	μA / MHz/ Enable
I_C	Total Power Supply Current ⁽⁶⁾	$V_{CC} = \text{Max.}$ Outputs Open 2 Enable Pins Toggling $f_i = 10\text{MHz}$ 50% Duty Cycle	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	2.4	3.2	mA
			$V_{IN} = 3.4$ $V_{IN} = GND$	—	2.9	4.7	

3255 tbl 07

NOTES:

- For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at $V_{CC} = 3.3V$, $+25^\circ C$ ambient.
- Per TTL driven input ($V_{IN} = 3.4V$). All other inputs at V_{CC} or GND .
- This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.
- $CPD = I_{CCD}/V_{CC}$
 CPD = Power Dissipation Capacitance
- $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$
 $I_C = I_{CC} + \Delta I_{CC} D_{HNT} + I_{CCD} (f_i N)$
 I_{CC} = Quiescent Current
 ΔI_{CC} = Power Supply Current for a TTL High Input ($V_{IN} = 3.4V$)
 D_H = Duty Cycle for TTL Inputs High
 N_T = Number of TTL Inputs at D_H
 I_{CCD} = Dynamic Current Caused by an Input Transition Pair (HLH or LHL)
 f_i = Control Input Frequency
 N = Number of Control Inputs Toggling at f_i

SWITCHING CHARACTERISTICS OVER OPERATING RANGE

Following Condition Apply Unless Otherwise Specified:

Operating Conditions: $T_A = -40^\circ C$ to $+85^\circ C$, $V_{CC} = 5.0V \pm 5\%$

Symbol	Description ⁽¹⁾	Min.	Typ.	32244	32244	Unit
				Max.		
tPLH tPHL	Data Propagation Delay A to B, B to A ⁽²⁾	—	—	0.25	1.25	ns
tPZH tPZL	Switch CONNECT Delay xOE to A or B	1.5	—	6.5	5.6	ns
tPHZ tPLZ	Switch DISCONNECT Delay xOE to A or B	1.5	—	5.5	5.2	ns
QCI	Charge Injection During Switch DISCONNECT, xOE to A or B ⁽³⁾	—	1.5	—	—	pC

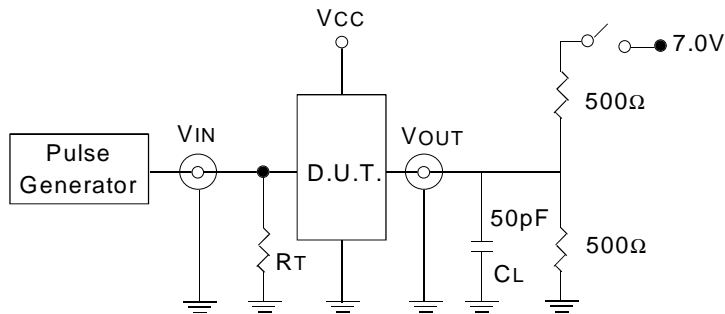
3255 tbl 08

NOTES:

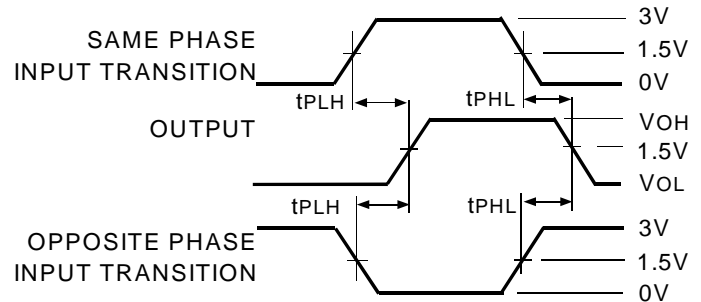
- See test circuits and waveforms.
- The bus switch contributes no Propagation Delay other than the RC Delay of the load interacting with the RC of the switch.
- IQ_{CI} is the charge injection for a single switch DISCONNECT and applies to either single switches or multiplexers.
 IQ_{DCI} is the charge injection for a multiplexer as the multiplexed port switches from one path to another. Charge injection is reduced because the injection from the DISCONNECT of the first path is compensated by the CONNECT of the second path.

TEST CIRCUITS AND WAVEFORMS

TEST CIRCUITS FOR ALL OUTPUTS



PROPAGATION DELAY



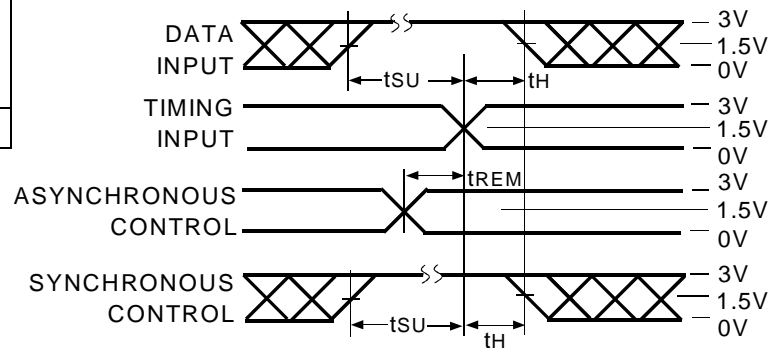
SWITCH POSITION

Test	Switch
Open Drain	Closed
Disable Low	
Enable Low	
All Other Tests	Open

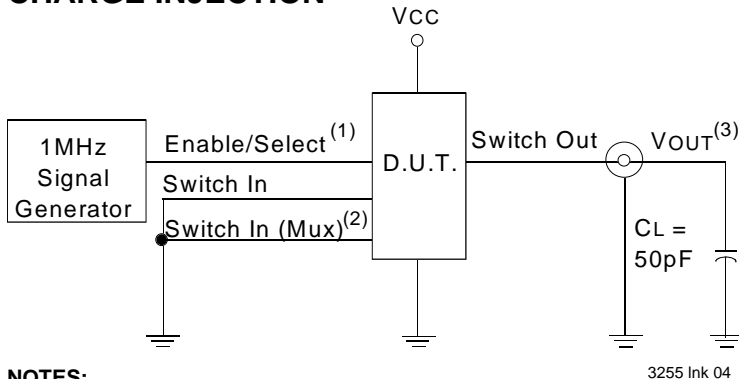
DEFINITIONS:

CL = Load capacitance: includes jig and probe capacitance.
RT = Termination resistance: should be equal to ZOUT of the Pulse Generator

SET-UP, HOLD AND RELEASE TIMES



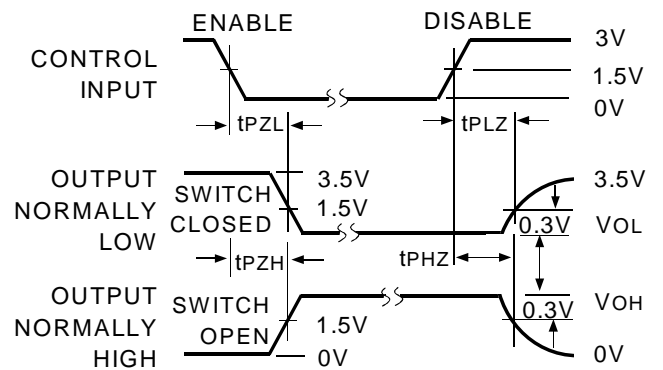
CHARGE INJECTION



NOTES:

- Select is used with multiplexers for measuring |QDCI| during multiplexer select. During all other tests Enable is used.
- Used with multiplexers to measure |QDCI| only.
- Charge Injection = $\Delta V_{OUT} C_L$, with Enable toggling for |QCI| or Select toggling for |QDCI|. ΔV_{OUT} is the change in VOUT and is measured with a 10MΩ probe.

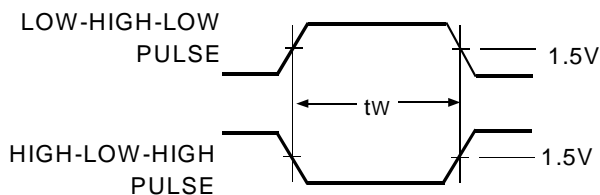
ENABLE AND DISABLE TIMES



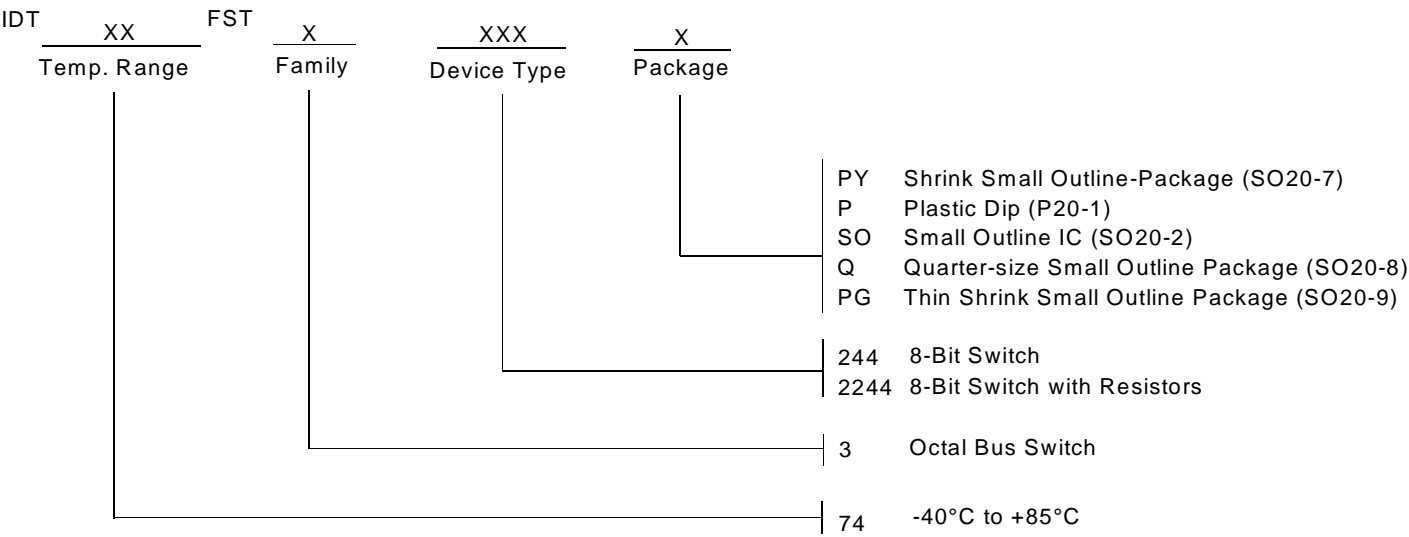
NOTES:

- Diagram shown for input Control Enable-LOW and input Control Disable HIGH
- Pulse Generator for All Pulses: Rate $\leq 1.0\text{MHz}$; $t_F \leq 2.5\text{ns}$; $t_R \leq 2.5\text{ns}$

PULSE WIDTH



ORDERING INFORMATION



3255 drw 09